

 Application/Control No.	Applicant(s)/Patent under Reexamination	
09/605,289	LIPSON ET AL.	
Examiner	Art Unit	
Sheela C. Chawan	2624	

SEARCHED					
Class	Subclass	Date	Examiner		
382	147	4/13/2006	scc		
382	149	4/13/2006	scc		
382	256	4/13/2006	scc		
361	720	4/13/2006	scc		
707	102	4/13/2006	scc		
ABOVE	SEARCH	4/13/2006	scc		
UP-DAT.					

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
382	147, 149	4/13/2006	scc		
382	256	4/13/2006	scc		
361	720	4/13/2006	scc		
707/102		4/13/2006	scc		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST, US-PGPUB, USPAT, EPO,JPO,DERWENT, IBM-TDB, SEE SEARCH HISTORY PRINTOUT AND UPDATE THE SEARCH.	4/13/2006	scc			
382/147,149,256.CCLS 361/720.CCLS. 707/102.CCLS. US-PATENT ONLY, SEE TEXT SEARCH.	4/13/2006	scc			
INVENTOR NAME SEARCH.	4/13/2006	scc			
SEARCH INSPEC DATABASE.	4/13/2006	scc			
INTERFERENCE SEARCH, SEE SEARCH HISTORY PRINT OUT.	4/13/2006	scc			
346/135, 580, 583, 586, ABOLISH.	4/13/2006	scc			